# Carrier recombination dynamics in In<sub>x</sub>Ga<sub>1-x</sub>N/GaN multiple quantum wells

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We have measured the carrier recombination dynamics in InGaN/GaN multiple quantum wells over an unprecedented range in intensity and time by means of time-resolved photoluminescence spectroscopy. We find that, at times shorter than 30 ns, they follow an exponential form and a power law at times longer than 1  $\mu$ s. To explain these biphasic dynamics, we propose a simple three-level model where a charge-separated state interplays with the radiative state through charge transfer following a tunneling mechanism. We show how the distribution of distances in charge-separated states controls the dynamics at long time. Our results imply that charge recombination happens on nearly isolated clusters of localization centers.

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# I. INTRODUCTION

In<sub>r</sub>Ga<sub>1-r</sub>N/GaN heterostructures are essential for the production of optoelectronic devices, such as blue/ultraviolet lasers and light-emitting diodes, with external quantum efficiencies approaching 75%.<sup>1-3</sup> The physical mechanisms that result in such high efficiencies are still poorly understood, as high threading dislocation densities due to epitaxial growth on mismatched sapphire substrates are believed to induce numerous nonradiative carrier recombination centers in these heterostructures.<sup>4-6</sup> It is generally assumed that because of the large electron and hole effective masses in InGaN, nanoscopic potential fluctuations induce a strong localization of the carrier wave function.<sup>7,8</sup> Evidence for carrier localization in In-rich clusters<sup>9,10</sup> and antilocalization near threading dislocations<sup>5,11,12</sup> has been reported. Such a localization has a profound impact on carrier dynamics, which can be unraveled through time-resolved photoluminescence (PL) measurements. The PL decay from InGaN/GaN heterostructures is highly nonexponential  $^{9,10,13-18}$  but a detailed understanding of these particular dynamics is still lacking.

Early studies concluded that the recombination dynamics could be well described by a stretched exponential (SE).<sup>9,10,14–17</sup> Stretched exponentials are often observed in highly disordered materials,<sup>19</sup> where they are assigned to the summation of monoexponential decays originating from individual localization centers with different exciton lifetimes.<sup>10</sup> The quantum-confined Stark effect has also been invoked to explain the carrier dynamics. It is induced in InGaN/GaN heterostructures by the large electric fields that result from the mechanical constraints inherently present in epitaxially grown nitrides, combined with high piezoelectric coefficients. It leads to nonexponential recombination dynamics, redshift of the emission energy with time, and excitation density dependence on the emission energy.<sup>18</sup> The quantum-confined Stark effect is mostly observed in wide InGaN quantum wells (QWs) since in QWs whose thickness is less than the exciton Bohr radius the *e*-*h* overlap integral is not modified by the presence of electric fields.<sup>20</sup> The localization of electrons and holes on separate sites has also been reported.<sup>11,21,22</sup> The amphoteric character of the localization centers has led to proposals of a bidimensional donoracceptor like (2D-DAP) recombination model where electrons and holes are localized on the opposite sides of the QWs. The 2D-DAP model was found to reproduce the PL decay dynamics of InGaN/GaN QWs over three decades in intensity.<sup>21</sup> Recently, the nonexponential PL dynamics of ensembles of localized centers have been linked to the PL intermittency, also called blinking, of individual centers whose emission is observed under continuous excitation conditions.<sup>23,24</sup> Blinking is observed in a variety of systems such as colloidal and self-assembled quantum dots (QDs) (Refs. 23 and 25–27) and Si nanocrystals,<sup>24</sup> and is attributed to the formation of metastable, charge-separated (CS) dark states.<sup>28,29</sup>

In this paper, we present ensemble measurements of the carrier recombination dynamics in InGaN/GaN QWs over a time window that allows us to follow the PL decay over six decades in intensity. We observe a previously unreported slowing down of the decay dynamics at times longer than 200 ns that cannot be explained by stretched exponential, quantum-confined Stark effect or 2D-DAP models. We propose a three-level recombination model involving a dark CS state to explain our results. We conclude that, in thin InGaN/GaN QWs, radiative recombination happens on nearly isolated islands of agglomerated localization centers.

# **II. EXPERIMENTAL DETAILS**

The InGaN/GaN samples were grown on *c*-plane sapphire substrates by metalorganic chemical vapor deposition. Fiveperiod In<sub>x</sub>Ga<sub>1-x</sub>N/GaN QWs were grown on 2  $\mu$ m *n*-GaN with a nominal In composition *x*=0.2. The thickness of the GaN barriers was 14.0 and that of the InGaN wells between 2 and 4 nm. On top of the multiple QW structure, 14 nm of *p*-AlGaN and 100 nm of *p*-GaN were deposited.

Time-resolved PL measurements were performed using a Ti:sapphire laser system with a repetition rate of 1 kHz and a pulse duration of 40 fs. The second harmonic (390 nm) of the laser beam, generated with a type-I  $\beta$ -BBO crystal, was focused on the samples with an excitation density of about  $3 \times 10^2$  W cm<sup>-2</sup>, corresponding to  $6 \times 10^{12}$  photons cm<sup>-2</sup> per pulse. This excitation density is well within the linear regime of our samples. The samples were cooled to 9 K in a



FIG. 1. (Color online) Time-resolved PL spectra of the sample with 2 nm QWs. TIPL is the time-integrated emission.  $E_{exc}$ =3.18 eV.

cold-finger liquid-helium continuous-flow cryostat. As the excitation photon energy (3.18 eV) is lower than the low-temperature GaN band gap (3.5 eV), the carriers were photogenerated directly in the QWs. The PL signal was analyzed with a 0.3 m grating spectrometer and detected with a gated, intensified charge-coupled device. The time evolution of the emission spectrum was acquired with a temporal resolution of 5 ns.

#### **III. RESULTS AND DISCUSSION**

The PL spectra of our samples showed multimodal emission spanning the range 2.2–3.1 eV. All samples exhibited nonexponential decay dynamics with similar temporal dynamics. The time-resolved PL spectra of the sample with 2 nm QWs are presented in Fig. 1. Three bands can be distinguished. Band A, at 2.81 eV, has a lifetime shorter than 4 ns. We attribute it to QW free-exciton recombination. Band B peaks at 2.74 eV. After a rapid energy shift for t < 4 ns, its shape and energy position remain constant with time. At times longer than 1  $\mu$ s, band C can be observed at 2.65 eV. The time-integrated PL spectrum is close to that of the timeresolved emission at 10 ns. As band B dominates the emission, we focus on its dynamics in what follows.

Figure 2 shows the decay of the emission from band B integrated from 2.73 to 2.76 eV. For times shorter than 30 ns, the intensity decreases rapidly and its dynamics are compatible with a stretched exponential. At longer times however, the dynamics slow down and tend to a power law  $t^{-\alpha}$  with  $\alpha = 1.3$  for t > 200 ns, as can be seen on Fig. 2(b). The long-lived tail on the decay curve, which accounts for about 20% of the time-integrated intensity, imposes stringent constraints on any dynamical model.

The absence of spectral shift with time, the invariance of the decay curve with excitation density, together with the small thickness of the InGaN QWs, rules out the presence of a quantum-confined Stark effect in our samples. Further, the significant proportion of photons emitted in the long-lived tail implies that the power law it is not caused by a rare occurrence of localization centers or impurities. In addition, the shape preservation of bands with time and the energy independence of the decay dynamics, indicates the presence of a single recombination mechanism.

Within the stretched exponential model, the PL intensity is assumed to follow

$$I(t) = I_0 \exp\{-(\Gamma t)^{\beta}\}.$$
 (1)

As can be seen in Fig. 2(a), Eq. (1) reproduces our data with the parameters listed in Table I only for t < 30 ns, that is, for less than two decades in intensity. Thus, in our samples, the stretched exponential model is at best a phenomenological description at short times.



FIG. 2. (Color online) PL decay of band B. (a) Semilogarithmic plot and (b) double-logarithmic plot. The solid lines are the best fits using the SE, 2D-DAP, and CS models.

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TABLE I. Parameters obtained by fitting the SE, 2D-DAP, and CS models to the experimental data. The numbers in parenthesis are the uncertainties on the values of the parameters.

		Г			
		$(10^8 \ s^{-1})$	β	γ	$\mu$
SE		1.22 (0.08)	0.83 (0.09)		
2D-DAP		1.1 (0.1)		0.28 (0.02)	
CS	$\Gamma_{rad}$	0.84 (0.06) <sup>a</sup>			0.30 (0.01)
	$\Gamma_{esc}$	11 (2) <sup>a</sup>			

<sup>a</sup>Values obtained with  $\nu = 2 \times 10^{13} \text{ s}^{-1}$ .

The 2D-DAP model implies a decay dynamics that  $\operatorname{follow}^{21}$ 

$$I(t) = 2\pi n \int_0^\infty W(r) e^{-W(r)t} r dr$$
$$\times \exp\left\{2\pi n \int_0^\infty (e^{-W(r)t} - 1) r dr\right\}, \qquad (2)$$

where  $W(r) = \Gamma e^{-r^2/a^2}$  represents the recombination rate for an electron-hole pair separated by a distance *r*, *a* is the Bohr radius, and *n* is the majority-carrier saturation density. Equation (2) implies that the temporal shape of the PL decay remains the same in all samples where  $\gamma = na^2$  is constant. Such a time-scale invariance was indeed reported by Morel *et al.*<sup>21</sup>

Figure 2 shows the best fit of our data with Eq. (2). A good agreement is achieved for times up to about 200 ns with the optimized parameters listed in Table I. The value obtained for  $\gamma$  in our samples is close to that obtained by Morel *et al.*<sup>21</sup> This indicates that our sample has a similar short-time decay dynamics. However, the 2D-DAP model fails to reproduce the decay slowing down observed at t > 200 ns.

Sher *et al.*<sup>23</sup> introduced a three-level CS model to describe both PL blinking and nonexponential recombination dynamics in colloidal quantum dots. It is based on the interplay between a *bright state* (1) that corresponds to an electron and a hole on the same localization center and a *dark state* (2) where the carriers are spatially separated, as schematized in Fig. 3. Luminescence comes from transitions  $1 \rightarrow 0$  with a rate constant  $\Gamma_{rad}$  while transitions  $1 \rightarrow 2$  occur with a rate constant  $\Gamma_{esc}$ . Within the CS model, the charge separation induces a local modification of the potential landscape that affects the back transfer  $2 \rightarrow 1$ . If one assumes that the back transfer occurs by tunneling, the distribution of time spent in the dark state is

$$R(t) = \int_0^\infty f(r)k(r)e^{-k(r)t}dr,$$
(3)

where *r* is the distance between the carriers,  $k(r) = \nu e^{-\eta r}$  is the tunneling rate, and f(r) is the spatial distribution of charge separation.<sup>28</sup> Within the CS model, the PL intensity is given by



FIG. 3. CS recombination model. State 1 corresponds to an electron and a hole on the same localization center. State 2 corresponds to carriers localized on different centers. Radiative transitions from state 1 to the ground state occur with rate constant  $\Gamma_{rad}$  and charge separation from state 1 to state 2 occurs with a rate constant  $\Gamma_{esc}$ .

$$I(t) \propto \Gamma_{rad} x_1(t), \tag{4a}$$

where  $x_1$  is the population of state 1 and

$$\frac{dx_{1}(t)}{dt} = -(\Gamma_{rad} + \Gamma_{esc})x_{1}(t) + \int_{0}^{t} \Gamma_{esc}x_{1}(t')R(t-t')dt'.$$
(4b)

In the Laplace domain,

$$\hat{x}_1(s) = (s + \Gamma_{rad} + \Gamma_{esc}[1 - \hat{R}(s)])^{-1}$$
 (5a)

with

$$\hat{R}(s) = \int_0^\infty \frac{f(r)k(r)}{s+k(r)} dr.$$
(5b)

If an exponential spatial distribution is assumed,  $f(r) = \epsilon e^{-\epsilon r}$ and

$$\hat{R}(s) = \mu \int_0^\infty \frac{e^{-(1+\mu)x}}{s/\nu + e^{-x}} dx,$$
(6)

where  $x = \eta r$  and  $\mu = \epsilon / \eta$ .  $\hat{R}(s)$  can be evaluated through numerical integration of Eq. (6) and I(t) by an inverse Laplace transform of Eq. (5a) using the Gaver-Stehfest algorithm.<sup>30</sup> The CS model predicts biphasic dynamics. At short times, the PL decays exponentially,  $I(t) \propto e^{-\Gamma_{rad}t}$ , while it follows a power law at long times,  $I(t) \approx t^{-(1+\mu)}$ . Equations (4b) and (6) indicate that  $\nu$  and  $\Gamma_{esc}$  cannot be determined independently. For a given tunnel attempt frequency  $\nu$ ,  $\Gamma_{esc}$  controls the strength of the long-time power-law component with respect to the short-time exponential one.

As shown in Fig. 2, the CS model reproduces the experimental results throughout the entire range of the measurement with a vibroniclike attempt frequency<sup>31</sup> and the optimized parameters listed in Table I. However, excellent agreement can still be obtained over a wide range of attempt frequencies; our simulations show that  $\Gamma_{esc} \gtrsim \Gamma_{rad}$  and  $\nu > 10^{10} \text{ s}^{-1}$ .

Within our model, the distribution of distances f(r) controls the recombination dynamics. We have tested that only rapidly decreasing functions, such as an exponential, can reproduce our results. This implies that carriers are confined in

nearly isolated islands of grouped localization centers. Thus, one can hypothesize that many localization centers are in fact present in a single quantum dot.

The CS model is based on microscopic physical processes similar to the 2D-DAP model, as both models involve charge separation. Within the CS model however, the chargeseparated state is dark and can be recycled from the bright state. It is this recycling that causes the decay slowing down observed at long times. As indicated above, the 2D-DAP model explains nicely the PL decay shape invariance reported in similar InGaN/GaN samples. The CS model also obeys a time-scale invariance law. This can be seen from Eq. (5a), which can be approximated by<sup>28</sup>

$$\hat{x}_1(s) \approx \left[s + \Gamma_{rad} + \Gamma_{esc} \frac{\pi\mu}{\sin(\pi\mu)} \left(\frac{s}{\nu}\right)^{\mu}\right]^{-1}.$$
 (7)

Equation (7) breaks down for  $\mu = 1$  but reproduces well the decay dynamics for  $\mu < 1$ . It follows that the temporal shape of the PL decay is invariant if  $\Gamma_{rad}^{\mu-1}\Gamma_{esc}\nu^{-\mu}$  remains constant. Thus, within the CS model, the radiative rate of the bright state  $\Gamma_{rad}$  is linked to the escape rate to the dark state  $\Gamma_{esc}$  and to the back-transfer attempt frequency  $\nu$ . Further experimental and theoretical work is required to ascertain the physical origin of this time-scaling law.

Our results also allow to estimate the energy barrier between the dark and bright states,  $E_{loc}$ , from the back-transfer tunnel rate  $\eta = (8mE_{loc}\hbar^{-2})^{1/2}$ . Given the composition of our wells, one can estimate the electronic effective mass as  $m=0.18m_0.^{32}$  The fit of recombination dynamics gives  $\mu=0.30$ . Assuming intradot carrier localization, the

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- <sup>†</sup>richard.leonelli@umontreal.ca
- <sup>1</sup>S. P. Shuji Nakamura and G. Fasol, *The Blue Laser Diode* (Springer-Verlag, Berlin, 2000).
- <sup>2</sup>B. Gil, *Low-Dimensional Nitride Semiconductors* (Oxford University Press, New York, 2002).
- <sup>3</sup>Y. Narukawa, M. Sano, M. Ichikawa, S. Minato, T. Sakamoto, T. Yamada, and T. Mukai, Jpn. J. Appl. Phys., Part 2 **46**, L963 (2007).
- <sup>4</sup>S. J. Rosner, E. C. Carr, M. J. Ludowise, G. Girolami, and H. I. Erikson, Appl. Phys. Lett. **70**, 420 (1997).
- <sup>5</sup>A. Kaneta, M. Funato, and Y. Kawakami, Phys. Rev. B **78**, 125317 (2008).
- <sup>6</sup>T. Sugahara, H. Sato, M. Hao, Y. Naoi, S. Kurai, S. Tottori, K. Yamashita, K. Nishino, L. T. Romano, and S. Sakai, Jpn. J. Appl. Phys., Part 2 **37**, L398 (1998).
- <sup>7</sup>H. Schömig, S. Halm, A. Forchel, G. Bacher, J. Off, and F. Scholz, Phys. Rev. Lett. **92**, 106802 (2004).
- <sup>8</sup>D. M. Graham, A. Soltani-Vala, P. Dawson, M. J. Godfrey, T. M. Smeeton, J. S. Barnard, M. J. Kappers, C. J. Humphreys, and E. J. Thrush, J. Appl. Phys. **97**, 103508 (2005).
- <sup>9</sup>I. L. Krestnikov, N. N. Ledentsov, A. Hoffmann, D. Bimberg, A.

characteristic distance between localization centers is then  $1/\epsilon \approx 3-6$  nm.<sup>12,33,34</sup> One then estimates  $E_{loc} \approx 25-50$  meV.

The proposed model for recombination dynamics in In-GaN also seems to be valid in a variety of materials such as colloidal QDs (Ref. 23) or polymer distributed heterostructures.<sup>35</sup> This indicates that the interaction of a charge-separated state with a radiative state plays a crucial role in the determination of long-time carriers recombination dynamics in systems with some degree of disorder.

### **IV. CONCLUSION**

We have measured the time-resolved photoluminescence of InGaN/GaN multiple quantum wells over an unprecedented range in intensity. The dynamics show a slowing down at long times that cannot be explained by currents models. Rather, it can be well modeled by a simple threelevel system with a *dark* charge-separated state and a *bright* radiative state. The interplay between the dark and bright states, through back-transfer tunneling, dominates the recombination dynamics at long times. Our results indicate that the distribution of distance between charge-localization centers decreases rapidly with distance. This implies that the radiative recombination happens on nearly isolated islands of agglomerated localizations centers.

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- V. Sakharov, W. V. Lundin, A. F. Tsatsul'nikov, A. S. Usikov, Z. I. Alferov, Y. G. Musikhin, and D. Gerthsen, Phys. Rev. B **66**, 155310 (2002).
- <sup>10</sup>T. Bartel, M. Dworzak, M. Strassburg, A. Hoffmann, A. Strittmatter, and D. Bimberg, Appl. Phys. Lett. 85, 1946 (2004).
- <sup>11</sup>A. Hangleiter, C. Netzel, D. Fuhrmann, F. Hitzel, L. Hoffmann, H. Bremers, U. Rossow, G. Ade, and P. Hinze, Philos. Mag. 87, 2041 (2007).
- <sup>12</sup>Y. Narukawa, Y. Kawakami, M. Funato, S. Fujita, S. Fujita, and S. Nakamura, Appl. Phys. Lett. **70**, 981 (1997).
- <sup>13</sup>Y. Sun, Y.-H. Cho, E.-K. Suh, H. J. Lee, R. J. Choi, and Y. B. Hahn, Appl. Phys. Lett. **84**, 49 (2004).
- <sup>14</sup>M. Pophristic, F. H. Long, C. Tran, I. T. Ferguson, and R. F. Karlicek, Jr., J. Appl. Phys. **86**, 1114 (1999).
- <sup>15</sup>S. Chichibu, T. Onuma, T. Sota, S. P. DenBaars, S. Nakamura, T. Kitamura, Y. Ishida, and H. Okumura, J. Appl. Phys. **93**, 2051 (2003).
- <sup>16</sup>T. Onuma, A. Chakraborty, B. A. Haskell, S. Keller, S. P. Den-Baars, J. S. Speck, S. Nakamura, U. K. Mishra, T. Sota, and S. F. Chichibu, Appl. Phys. Lett. **86**, 151918 (2005).
- <sup>17</sup>S.-Y. Kwon, H. J. Kim, E. Yoon, Y. Jang, K.-J. Yee, D. Lee, S.-H. Park, D.-Y. Park, H. Cheong, F. Rol, and L. S. Dang, J. Appl. Phys. **103**, 063509 (2008).

- <sup>18</sup>P. Lefebvre, S. Kalliakos, T. Bretagnon, P. Valvin, T. Taliercio, B. Gil, N. Grandjean, and J. Massies, Phys. Rev. B **69**, 035307 (2004).
- <sup>19</sup>H. Scher, M. Shlesinger, and J. Bender, Phys. Today 44(1), 26 (1991).
- <sup>20</sup>P. Bigenwald, P. Lefebvre, T. bretagon, and B. Gil, Phys. Status Solidi A **216**, 371 (1999).
- <sup>21</sup>A. Morel, P. Lefebvre, S. Kalliakos, T. Taliercio, T. Bretagnon, and B. Gil, Phys. Rev. B 68, 045331 (2003).
- <sup>22</sup>S. Kalliakos, X. B. Zhang, T. Taliercio, P. Lefebvre, B. Gil, N. Grandjean, B. Damilano, and J. Massies, Appl. Phys. Lett. 80, 428 (2002).
- <sup>23</sup>P. H. Sher, J. M. Smith, P. A. Dalgarno, R. J. Warburton, X. Chen, P. J. Dobson, S. M. Daniels, N. L. Pickett, and P. O'Brien, Appl. Phys. Lett. **92**, 101111 (2008).
- <sup>24</sup>K. Dunn, J. Derr, T. Johnston, M. Chaker, and F. Rosei, Phys. Rev. B **80**, 035330 (2009).
- <sup>25</sup> M. Nirmal, B. O. Dabbousi, M. G. Bawendi, J. J. Macklin, J. K. Trautman, T. D. Harris, and L. E. Brus, Nature (London) **383**, 802 (1996).

- <sup>26</sup>M. Kuno, D. P. Fromm, A. Gallagher, D. J. Nesbitt, O. I. Micic, and A. J. Nozik, Nano Lett. 1, 557 (2001).
- <sup>27</sup>D. Bertram, M. C. Hanna, and A. J. Nozik, Appl. Phys. Lett. **74**, 2666 (1999).
- <sup>28</sup>M. Tachiya and K. Seki, Appl. Phys. Lett. **94**, 081104 (2009).
- <sup>29</sup>J. Zhao, G. Nair, B. R. Fisher, and M. G. Bawendi, Phys. Rev. Lett. **104**, 157403 (2010).
- <sup>30</sup>H. Stehfest, Commun. ACM **13**, 47 (1970).
- <sup>31</sup>A. C. Morteani, A. S. Dhoot, J.-S. Kim, C. Silva, N. C. Greenham, C. Murphy, E. Moons, S. Ciná, J. H. Burroughes, and R. H. Friend, Adv. Mater. **15**, 1708 (2003).
- <sup>32</sup>P. Rinke, M. Winkelnkemper, A. Qteish, D. Bimberg, J. Neugebauer, and M. Scheffler, Phys. Rev. B 77, 075202 (2008).
- <sup>33</sup>S. Chichibu, T. Azuhata, T. Sota, and S. Nakamura, Appl. Phys. Lett. **69**, 4188 (1996).
- <sup>34</sup>I. P. Soshnikov, V. V. Lundin, A. S. Usikov, I. P. Kalmykova, N. N. Ledentsov, A. Rosenauer, B. Neubauer, and D. Gerthsen, Semiconductors **34**, 621 (2000).
- <sup>35</sup>S. Gélinas, C.-N. Brosseau, O. Paré-Labrosse, I. A. Howard, K. R. Kirov, R. H. Friend, R. Leonelli, and C. Silva (unpublished).